

## CLAIMS

I claim:

- 5    1.    A method for wavelet-based seismic amplitude inversion, comprising:  
selecting a seismic data set comprising a plurality of time samples;  
selecting a plurality of time windows in the seismic data set; and  
determining a reflectivity for each time window, using time samples within the  
time window.
- 10    2.    The method of claim 1, wherein the step of selecting a plurality of time windows  
comprises:  
selecting a plurality of time samples in the seismic data set; and  
selecting a time window in the seismic data set around each time sample.
- 15    3.    The method of claim 1, wherein the step of determining a reflectivity comprises:  
selecting a reference time sample in the time window; and  
determining a reflectivity for the reference time sample, using time samples  
within the time window.
- 20    4.    The method of claim 3, wherein the step of determining a reflectivity comprises:  
determining zero-offset reflectivities at all time samples in the time window;  
selecting a sequence of time samples in the time window;  
performing the following steps for each of the sequence of time samples:  
25            calculating a ratio of zero-offset reflectivities at the reference time sample  
                 and the selected time sample; and  
                 scaling the selected time sample by the ratio of zero-offset reflectivities;  
                 and  
calculating a reflectivity for the time window, using the scaled time samples.
- 30    5.    The method of claim 4, further comprising:

selecting a scaling up rejection factor;  
selecting a scaling down rejection factor;  
rejecting time samples that have a ratio of zero-offset reflectivities greater than  
the scaling up rejection factor; and

5        rejecting time samples that have a ratio of zero-offset reflectivities less than the  
scaling down rejection factor.

6.     The method of claim 4, further comprising:  
calculating a variance for the time window, using the scaled time samples.

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7.     The method of claim 3, wherein the step of determining a reflectivity comprises:  
determining zero-offset reflectivities at all time samples in the time window;  
selecting a sequence of time samples in the time window;  
performing the following steps for each of the sequence of time samples:

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calculating a ratio of zero-offset reflectivities at the reference time sample  
and the selected time sample; and  
calculating a reflectivity curve for the time sample; and  
scaling the time sample to the reflectivity curve by the ratio of zero-offset  
reflectivities; and

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calculating a reflectivity for the time window, using the scaled time samples.

8.     The method of claim 7, further comprising:

selecting a scaling up rejection factor;  
selecting a scaling down rejection factor;

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rejecting time samples that have a ratio of zero-offset reflectivities greater than  
the scaling up rejection factor; and

rejecting time samples that have a ratio of zero-offset reflectivities less than the  
scaling down rejection factor.

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9.     The method of claim 7, further comprising:  
calculating a variance for the time window.

10. The method of claim 3, wherein the step of determining a reflectivity comprises:  
determining zero-offset reflectivities at all time samples in the time window;  
selecting a sequence of time samples in the time window;  
5 performing the following steps for each of the sequence of time samples:  
calculating a ratio of zero-offset reflectivities at the reference time sample  
and the selected time sample; and  
calculating a parameterized reflectivity curve for the time sample; and  
scaling the reflectivity curve parameters by the ratio of zero-offset  
10 reflectivities; and  
calculating a reflectivity for the time window, using the scaled parameterized  
reflectivity curves.
11. The method of claim 10, further comprising:  
15 selecting a scaling up rejection factor;  
selecting a scaling down rejection factor;  
rejecting time samples that have a ratio of zero-offset reflectivities greater than  
the scaling up rejection factor; and  
rejecting time samples that have a ratio of zero-offset reflectivities less than the  
20 scaling down rejection factor.
12. The method of claim 10, further comprising:  
calculating a variance for the time window.